FORM PTO-1449	SERIAL NO.	CASE NO.
	To be Assigne	9281-4692
LIST OF PATENTS AND PUBLICATIONS FOR	FILING DATE	GROUP ART UNIT
APPLICANT'S INFORMATION DISCLOSURE STATEMENT	Herewith	2627
(use several sheets if necessary)	APPLICANT(S): Kiyoshi Sato	et al.

REFERENCE DESIGNATION U.S. PATENT DOCUMENTS

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EXAMINER	/Tianjie Chen/	DATE CONSIDERED	•	12/21/2006	•

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PTO-1449

LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT

(use several sheets if necessary)

-	SERIAL NO.	CASE NO.
	10/716,743	9281-4692
	FILING DATE November 17, 2003	
	APPLICANT(S): Kiyoshi Sato	et al.

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EXAMINER	/Tianjie Chen/	DATE CONSIDERED	08/28/2006

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